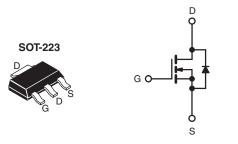


Vishay Siliconix

COMPLIANT

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.54		
Q _g (Max.) (nC)	8.3			
Q _{gs} (nC)	2.3			
Q _{gd} (nC)	3.8			
Configuration	Single			



N-Channel MOSFET

FEATURES

- Surface Mount
- · Available in Tape and Reel
- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOT-223 package is designed for surface-mounting using vapor phase, infrared, or wave soldering techniques. Its unique package design allows for easy automatic pick-and-place as with other SOT or SOIC packages but has the added advantage of improved thermal performance due to an enlarged tab for heatsinking. Power dissipation of greater than 1.25 W is possible in a typical surface mount application.

ORDERING INFORMATION					
Package	SOT-223	SOT-223			
Lead (Pb)-free	IRFL110PbF	IRFL110TRPbFa			
	SiHFL110-E3	SiHFL110T-E3 ^a			
SnPb	IRFL110	IRFL110TR ^a			
	SiHFL110	SiHFL110T ^a			

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS	T _C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$	I _D	1.5		
	VGS at 10 V	T _C = 100 °C		0.96	Α	
Pulsed Drain Current ^a			I _{DM}	12		
Linear Derating Factor				0.025	W/°C	
Linear Derating Factor (PCB Mount)e				0.017		
Single Pulse Avalanche Energy ^b			E _{AS}	150	mJ	
Repetitive Avalanche Current ^a			I _{AR}	1.5	Α	
Repetitive Avalanche Energy ^a			E _{AR}	0.31	mJ	
Maximum Power Dissipation	T _C =	25 °C	В	3.1	W	
Maximum Power Dissipation (PCB Mount)e	T _A =	25 °C	P_D	2.0	VV	
Peak Diode Recovery dV/dtc		dV/dt	5.5	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg} - 55 to + 150		°C	
Soldering Recommendations (Peak Temperature)	for	for 10 s		300 ^d	1	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L = 25 mH, $R_G=25$ Ω , $I_{AS}=3.0$ A (see fig. 12). c. $I_{SD}\leq 5.6$ A, $dI/dt\leq 75$ A/ μ s, $V_{DD}\leq V_{DS}$, $T_J\leq 150$ °C. d. 1.6 mm from case.

- When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFL110, SiHFL110

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	60	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	-	40		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	-	0.63	-	V/°C	
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	± 100	nA
Zaro Gato Voltago Drain Current	l	V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	ι. Λ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	V _{GS} = 0 V, T _J = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.90 A ^b	-	-	0.54	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.90 A	1.1	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,		180	-	
Output Capacitance	C _{oss}	$V_{DS} = 25 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	81	-	pF
Reverse Transfer Capacitance	C _{rss}			-	15	-	
Total Gate Charge	Qg		I _D = 5.6 A, V _{DS} = 80 V, see fig. 6 and 13 ^b	-	-	8.3	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	2.3	nC
Gate-Drain Charge	Q_{gd}	1	goo ng. o ana 10	-	-	3.8	
Turn-On Delay Time	t _{d(on)}				6.9	-	- ns
Rise Time	t _r	V_{DD} = 50 V, I_D = 5.6 A, R_G = 24 Ω , R_D = 8.4 Ω , see fig. 10 ^b		-	16	-	
Turn-Off Delay Time	t _{d(off)}			-	15	-	
Fall Time	t _f			-	9.4	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	ьU
Internal Source Inductance	L _S			-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol		-	1.5	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	12	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.5 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dI/dt = 100 A/μs ^b		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.44	0.88	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on is dominated by L _S and L _D)				

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

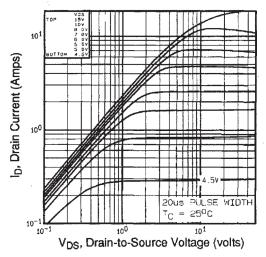


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

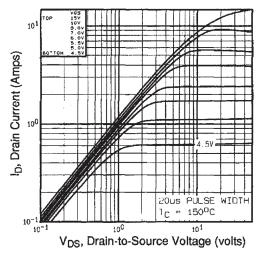


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

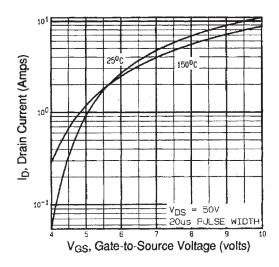


Fig. 3 - Typical Transfer Characteristics

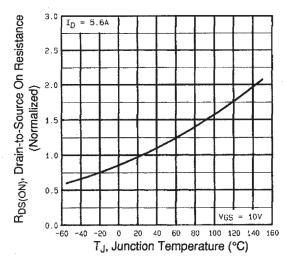


Fig. 4 - Normalized On-Resistance vs. Temperature

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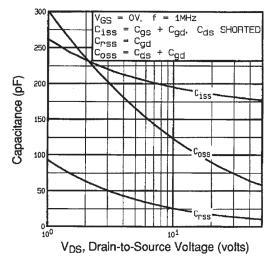


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

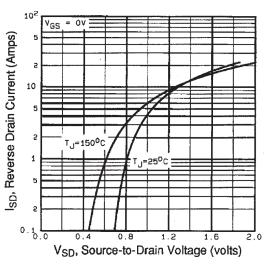


Fig. 7 - Typical Source-Drain Diode Forward Voltage

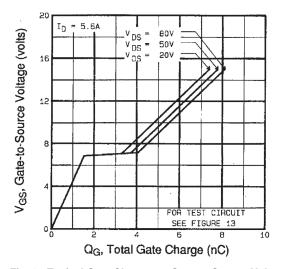


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

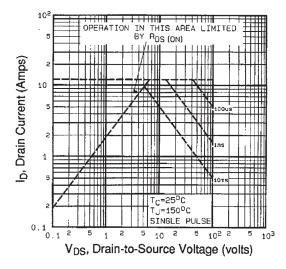


Fig. 8 - Maximum Safe Operating Area





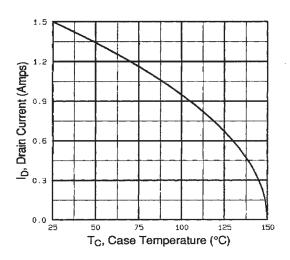


Fig. 9 - Maximum Drain Current vs. Case Temperature

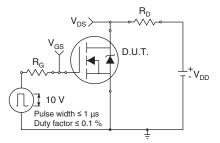


Fig. 10a - Switching Time Test Circuit

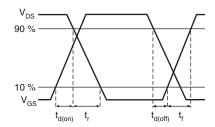


Fig. 10b - Switching Time Waveforms

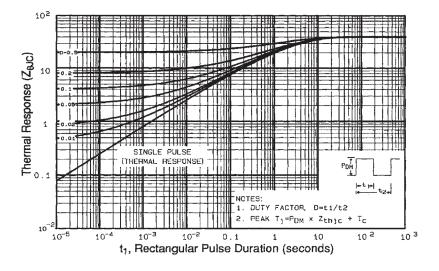


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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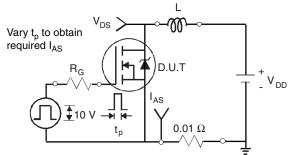


Fig. 12a - Unclamped Inductive Test Circuit

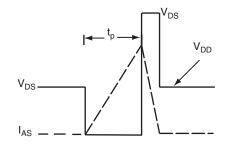


Fig. 12b - Unclamped Inductive Waveforms

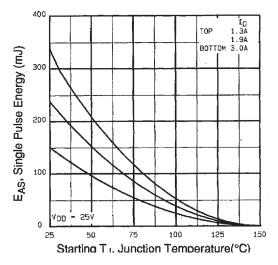


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

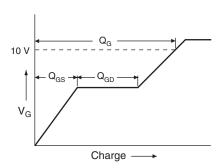


Fig. 13a - Basic Gate Charge Waveform

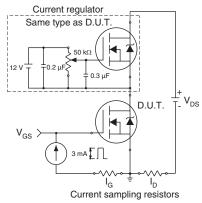
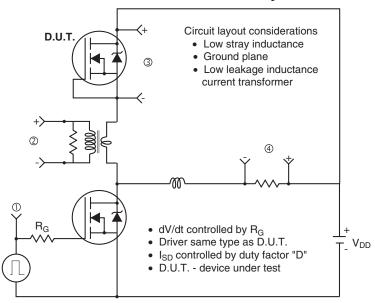
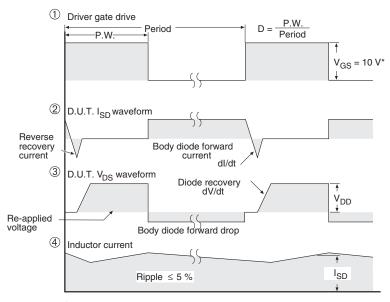


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig.14 - For N-Channel

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